

57X G12H5 G Revision 1 Page 1 of 4 January 1999

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CERTIFICATE OF ANALYSIS

57X G12H5 (batch G)

Certified Reference Material Information

Type: ALUMINIUM/COPPER/SILICON (CAST)

Form and Size: Disc 40-50mm diameter x 15-20mm thick

Supplied by: MBH Analytical Limited

Produced by: Coleshill Laboratories Limited

Certified Analysis

Percentage element by weight

Element	Cu	Mg	Si	Fe	Mn	Ni
%	12.2	0.028	0.55	0.19	0.073	0.11
Element	Zn	Pb	Sn	Со	Ti	Cr
%	0.072	0.068	0.067	0.054	0.036	0.016
Element	Zr	V	Sb	Be	Ga	Cd
%	0.045	0.033	0.066	0.003	0.017	0.023

Usage

Intended use: With optical emission and X-ray fluorescence spectrometers.

Recommended method of use

Aluminium and aluminium alloys are generally prepared by machining on a lathe. However, users are recommended to follow the calibration and sample preparation procedures specified by the relevant instrument

manufacturer.

Preparation should be the same for reference materials and the samples

for test.

A minimum of three consistent replicate analyses is recommended to optimise precision and accuracy. Users are advised to check against possible bias between reference materials and production samples due to differences in metallurgical history, and be aware of possible inter-element effects.

Certified by:

on 12th January 1999

MBH ANALYTICAL LIMITED _____





Method of Preparation

This reference material was produced from commercial-purity aluminium, pure elements and master alloys. The melt was degassed using sodium-free degasser, and was cast into iron chill moulds. 2mm has been removed from the cast face to minimise any surface effects.

Sampling

Samples for chemical analysis, and discs for homogeneity checks, were taken from the start, middle and end of the casting process

Homogeneity

For a series of three discs, 2mm was removed from the chilled face and then each disc checked for vertical uniformity using an optical emission spectrometer.

Multiple measurements were taken from each surface under test, and averaged.

The mean value of the material was then calculated from these averages.

For each of the surfaces checked, the differences between the averaged result and the overall mean value were checked to ensure that the homogeneity met the acceptance criteria defined in ISO guide 30 - 1992.

Chemical Analysis

Analysis was carried out on millings taken from samples representative of the cast product. For analysis purposes, the selected participating laboratories normally followed the requirements of ISO guide 25 - 1990. The individual values listed overpage are usually the average of each analyst's results.

Confidence Limits

These are the upper and lower values between which the actual measurements will fall, with the stated probabilities, assuming a Gaussian distribution.

68.3% of the results will fall within \pm 1 x Standard Deviation of the mean.

95.4% of the results will fall within \pm 2 x Standard Deviation of the mean.

99.7% of the results will fall within \pm 3 x Standard Deviation of the mean.

Analytical Data

-	Percentage element by weight									
Sample	Cu	Mg	Si	Fe	Mn	Ni				
1	12.2	0.025	0.56	0.20	0.080	0.105				
2	-	0.027	-	0.20	0.08	0.11				
3	12.40	0.027	0.56	0.20	-	0.11				
4	-	0.029	-	0.182	0.072	0.098				
5	-	0.03	-	0.18	0.07	-				
6	12.0	-	0.55	0.17	0.07	-				
7	12.21	0.025	-	0.184	0.07	0.105				
8	-	-	0.56	0.20	0.075	0.12				
9	12.04	0.031	0.51	0.187	0.07	-				
Mean	12.17	0.028	0.548	0.189	0.073	0.108				
Std Dev	0.16	0.002	0.022	0.011	0.004	0.007				
Sample	Zn	Pb	Sn	Со	Ti	Cr				
1	0.066	-	0.064	0.049	0.030	0.013				
2	0.07	0.063	-	0.05	0.04	0.015				
3	0.07	0.072	0.06	0.06	0.035	0.017				
4	-	0.066	0.068	-	0.038	-				
5	0.08	0.07	0.07	0.06	0.04	0.015				
6	0.08	0.07	0.07	0.05	0.03	-				
7	-	0.063	0.061	0.053	0.039	0.018				
8	0.072	0.073	0.078	-	-	-				
9	0.069	-	-	-	-	-				
Mean	0.072	0.068	0.067	0.054	0.036	0.016				
Std Dev	0.005	0.004	0.006	0.005	0.004	0.002				
Sample	Zr	V	Sb	Be	Ga	Cd				
1	0.04	0.033	0.066	0.0015	0.015	0.020				
2	0.04	0.03	-	0.003	0.017	0.03				
_ 3	0.05	0.035	-	0.003	-	0.020				
4	0.047	0.037	-	-	-	-				
5	-	0.03	-	-	-	-				
6	-	0.03	0.07	0.003	-	0.02				
7	0.05	-	0.058	0.003	0.018	-				
9	-	0.037	0.069	-	-	0.027				
Mean	0.045	0.033	0.066	0.0027	0.017	0.023				
Std Dev	0.005	0.003	0.005	0.0007	0.002	0.005				

Participating Laboratories

Metals Technology (Testing) Ltd RoTech Laboratories Sheffield Assay Office Coleshill Laboratories Ltd University Metals Advisory Centre London & Scandinavian Met Co Birmingham Assay Office Central Iron & Steel Research Inst Shiva Analyticals Ltd Sheffield, England Wednesbury, England Sheffield, England Birmingham, England Sheffield, England Rotherham, England Birmingham, England Beijing, China Bangalore, India NAMAS Approval 0963 NAMAS Approval 0366 NAMAS Approval 0012 NAMAS Approval 0121 NAMAS Approval 0411 NAMAS Approval 1091 NAMAS Approval 0667 National Reg. E0584

Analytical Methods Used

Copper: FAAS ICP Magnesium: FAAS ICP

Magnesium: FAAS ICP Silicon: FAAS ICP

Iron: FAAS ICP
Manganese: FAAS ICP
Nickel: FAAS ICP
Zinc: FAAS ICP

Lead: FAAS ICP
Tin: FAAS ICP

ICP Cobalt: FAAS FAAS Titanium: ICP Chromium: FAAS **ICP** FAAS **ICP** Zirconium: Vanadium: FAAS ICP FAAS ICP Antimony: Beryllium: **FAAS ICP** Gallium: FAAS ICP FAAS **ICP** Cadmium:

electrogravimetric

gravimetric photometric (molybdenum blue)

photometric (orthophenanthroline)

photometric (periodate)

photometric (dimethyl glyoxime) photometric (dithione extraction)

photometric (phenylfluorone)

Notes

This Certified Reference Material has been produced in accordance with the general principles of ISO Guide 34 - 1996. The certification conforms with the guidelines given in ISO Guide 31 - 1981.

To achieve NAMAS (UK National Measurement Accreditation Scheme) approval, test houses must demonstrate conformity to the general requirements of BS EN 45001, ISO Guide 25 and ISO9002.

Some cast discs may exhibit shrinkage cavities on their upper surfaces. The above certification is therefore only applicable to the front face of the disc. Material to the rear (engraved) face of the disc, to a depth of 5mm, is not certified.

Figures shown in brackets are not certified; they are provided for information only.

This material will remain stable provided adequate precautions are taken to protect it from cross-contamination, extremes of temperature and atmospheric moisture.

The material to which this certificate of analysis refers is supplied subject to our general conditions of sale.